

BFR340F

NPN Silicon RF Transistor

- General purpose Low Noise Amplifier
- Ideal for low current operation
- High breakdown voltage enables operation in automotive applications
- Minimum noise figure 1.0 dB @ 1mA,1.5V,1.9GHz
- Small package 1,2 x 1,2 mm² with visible leads
- Pb-free (RoHS compliant) package
- Qualified according AEC Q101



ESD (Electrostatic discharge) sensitive device, observe handling precaution!

Туре	Marking	Pin Configuration			Package
BFR340F	FAs	1 = B	2 = E	3 = C	TSFP-3

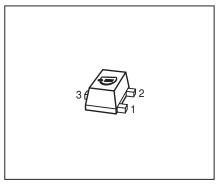
Maximum Ratings at $T_A = 25$ °C, unless otherwise specified

Parameter	Symbol	Value	Unit	
Collector-emitter voltage	V _{CEO}	6	V	
Collector-emitter voltage	V _{CES}	15		
Collector-base voltage	V _{CBO}	15		
Emitter-base voltage	V _{EBO}	2		
Collector current	I _C	20	mA	
Base current	I _B	2		
Total power dissipation ¹⁾	P _{tot}	75	mW	
<i>T</i> _S ≤ 110°C				
Junction temperature	TJ	150	°C	
Storage temperature	T _{Stg}	-55 150		

Parameter	Symbol	Value	Unit
Junction - soldering point ²⁾	R _{thJS}	≤ 530	K/W

 $^{1}T_{S}$ is measured on the collector lead at the soldering point to the pcb

²For calculation of R_{thJA} please refer to Application Note AN077 Thermal Resistance





Parameter	Symbol	Values			Unit
		min.	typ.	max.	Ī
DC Characteristics					
Collector-emitter breakdown voltage	V _{(BR)CEO}	6	9	-	V
$I_{\rm C}$ = 1 mA, $I_{\rm B}$ = 0					
Collector-emitter cutoff current	I _{CES}				nA
$V_{\rm CE}$ = 4 V, $V_{\rm BE}$ = 0, $T_{\rm A}$ = 25°C		-	1	30	
V_{CE} = 10 V, V_{BE} = 0, T_A = 85°C		-	2	50	
Verified by random sampling					
Collector-base cutoff current	I _{CBO}	-	1	30]
$V_{\rm CB} = 4 \text{V}, I_{\rm E} = 0$					
Emitter-base cutoff current	I _{EBO}	-	1	500]
$V_{\rm EB}$ = 1 V, $I_{\rm C}$ = 0					
DC current gain	h _{FE}	90	120	160	-
$I_{\rm C}$ = 5 mA, $V_{\rm CE}$ = 3 V, pulse measured					

Electrical Characteristics at $T_A = 25^{\circ}$ C, unless otherwise specified



Parameter	Symbol	Values			Unit
		min.	typ.	max.	
AC Characteristics (verified by random sampling	a)				
Transition frequency	f _T	11	14	-	GHz
<i>I</i> _C = 6 mA, <i>V</i> _{CE} = 3 V, <i>f</i> = 1 GHz					
Collector-base capacitance	C _{cb}	-	0.21	0.4	pF
$V_{CB} = 5 \text{ V}, f = 1 \text{ MHz}, V_{BE} = 0$,					
emitter grounded					
Collector emitter capacitance	C _{ce}	-	0.17	-]
$V_{CE} = 5 \text{ V}, f = 1 \text{ MHz}, V_{BE} = 0$,					
base grounded					
Emitter-base capacitance	C _{eb}	-	0.11	-	1
$V_{\rm EB}$ = 0.5 V, f = 1 MHz, $V_{\rm CB}$ = 0 ,					
collector grounded					
Minimum noise figure	NF _{min}				dB
$I_{\rm C}$ = 3 mA, $V_{\rm CE}$ = 1.5 V, $Z_{\rm S}$ = $Z_{\rm Sopt}$, f = 100 MHz		-	0.9	-	
$I_{\rm C}$ = 1 mA, $V_{\rm CE}$ = 1.5 V, $Z_{\rm S}$ = $Z_{\rm Sopt}$, f = 1.9 GHz		-	1	-	
$I_{\rm C}$ = 1 mA, $V_{\rm CE}$ = 1.5 V, $Z_{\rm S}$ = $Z_{\rm Sopt}$, f = 2.4 GHz		-	1.2	-	

Electrical Characteristics at $T_A = 25^{\circ}$ C, unless otherwise specified



Parameter	Symbol	Values			Unit
		min.	typ.	max.	
AC Characteristics (verified by random sampling)				
Maximum power gain ¹⁾	G _{max}				dB
$I_{\rm C}$ = 3 mA, $V_{\rm CE}$ = 1.5 V, $Z_{\rm S}$ = $Z_{\rm Sopt}$, $Z_{\rm L}$ = $Z_{\rm Lopt}$,					
<i>f</i> = 100 MHz		-	28	-	
$I_{\rm C}$ = 5 mA, $V_{\rm CE}$ = 3 V, $Z_{\rm S}$ = $Z_{\rm Sopt}$, $Z_{\rm L}$ = $Z_{\rm Lopt}$,					
<i>f</i> = 1.8 GHz		-	16.5	-	
<i>f</i> = 3 GHz		-	13	-	
Transducer gain	S _{21e} ²				dB
$I_{\rm C}$ = 3 mA, $V_{\rm CE}$ = 1.5 V, $Z_{\rm S}$ = $Z_{\rm L}$ = 50 Ω ,					
<i>f</i> = 100 MHz		-	19	-	
$I_{\rm C}$ = 5 mA, $V_{\rm CE}$ = 3 V, $Z_{\rm S}$ = $Z_{\rm L}$ = 50 Ω ,					
<i>f</i> = 1.8 GHz		-	14	-	
<i>f</i> = 3 GHz		-	10	-	
Third order intercept point at output ²⁾	IP ₃				dBm
V _{CE} = 3 V, / _C = 5 mA, <i>f</i> = 100 MHz,					
$Z_{\rm S} = Z_{\rm L} = 50\Omega$		-	14	-	
V _{CE} = 3 V, <i>I</i> _C = 5 mA, <i>f</i> = 1.8 GHz,					
$Z_{\rm S} = Z_{\rm L} = 50 \Omega$		-	13	-	
1dB compression point at output	P _{-1dB}				
$V_{\rm CE}$ = 3V, $I_{\rm C}$ = 5 mA, $Z_{\rm S}$ = $Z_{\rm L}$ = 50 Ω , f = 100 MHz		-	-3	-	
$V_{\rm CE}$ = 3V, $I_{\rm C}$ = 5 mA, $Z_{\rm S}$ = $Z_{\rm L}$ = 50 Ω , f = 1.8 GHz		-	-1	-	

Electrical Characteristics at $T_A = 25^{\circ}$ C, unless otherwise specified

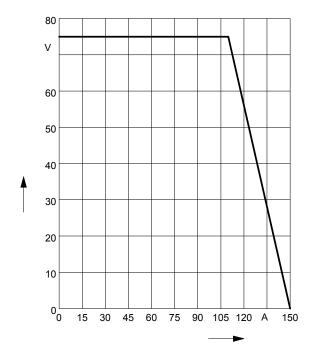
 ${}^{1}G_{ma} = |S_{21e} / S_{12e}| (k \cdot (k^{2} \cdot 1)^{1/2}), G_{ms} = |S_{21e} / S_{12e}|$

²IP3 value depends on termination of all intermodulation frequency components.

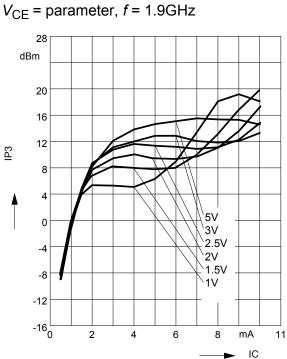
Termination used for this measurement is 50Ω from 0.1 MHz to 6 GHz

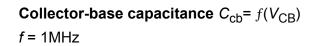


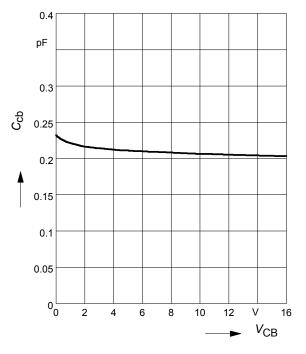
Total power dissipation $P_{tot} = f(T_S)$



Third order Intercept Point $IP_3=f(I_C)$ (Output, $Z_S=Z_L=50\Omega$)



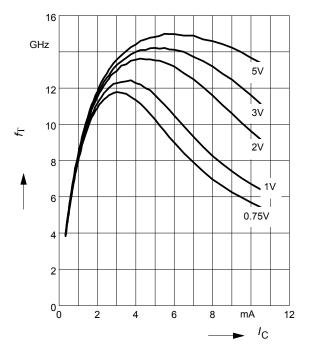




Transition frequency $f_{T} = f(I_{C})$

f = 1GHz

 V_{CE} = parameter

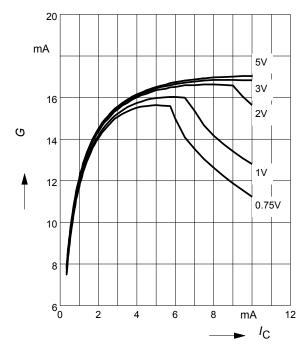




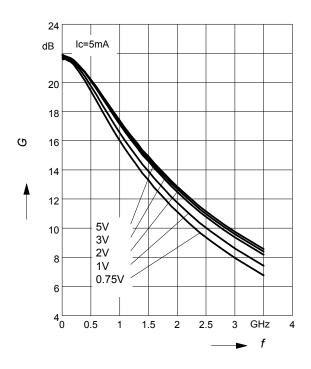
Power gain G_{ma} , $G_{ms} = f(I_C)$

f = 1.8GHz

 V_{CE} = parameter

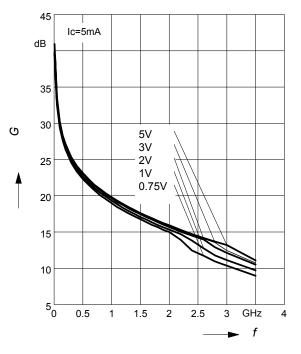


Insertion Power Gain $|S_{21}|^2 = f(f)$ V_{CE} = parameter



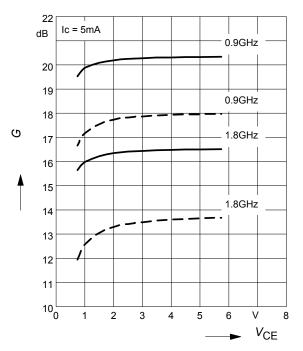
Power Gain G_{ma} , $G_{ms} = f(f)$





Power Gain G_{ma} , $G_{ms} = f(V_{CE})$: ---- $|S_{21}|^2 = f(V_{CE})$: ----

f = parameter

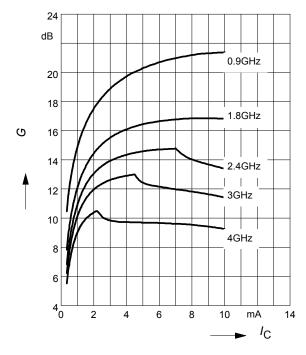




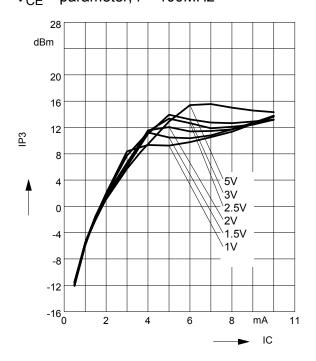


 $V_{CE} = 3V$

f = parameter

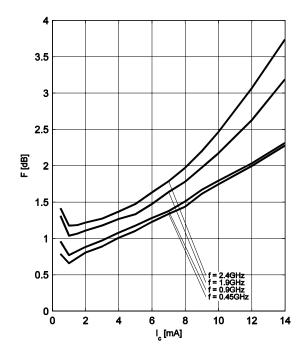


Third order Intercept Point $IP_3=f(I_C)$ (Output, $Z_S=Z_L=50\Omega$) V_{CE} = parameter, f = 100MHz

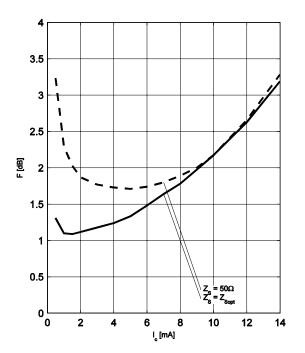


Noise figure $F = f(I_C)$

 V_{CE} = 1.5V, Z_{S} = Z_{Sopt}



Noise figure $F = f(I_C)$ $V_{CE} = 1.5V, f = 1.9GHz$

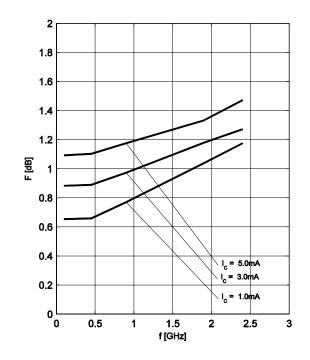


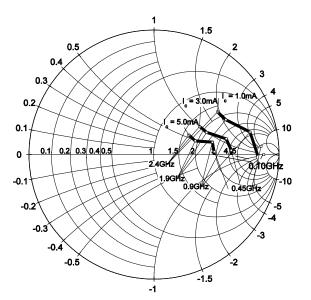


Noise figure F = f(f) $V_{CE} = 1.5V, Z_S = Z_{Sopt}, I_C = Parameter$ Source impedance for min.

noise figure vs. frequency

 V_{CE} = 1.5V, I_C=Parameter







SPICE Parameter

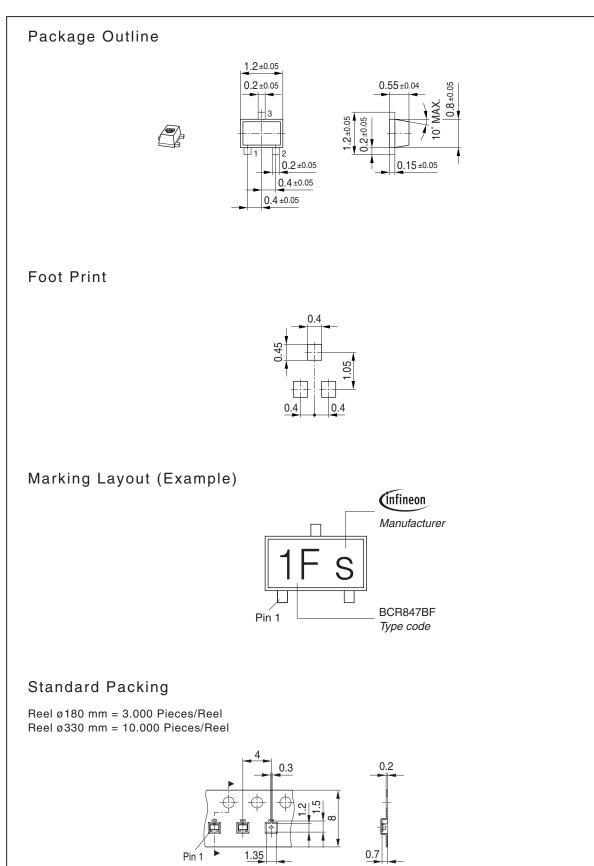
For the SPICE model as well as for the S-parameters (including noise parameters) please refer to our internet website <u>www.infineon.com/rf.models</u>.

Please consult our website and download the latest versions before actually starting your design.

You find the BFR340F SPICE model in the internet in MWO- and ADS- format which you can import into these circuit simulation tools very quickly and conveniently. The simulation data have been generated and verified using typical devices. The BFR340F SPICE model reflects the typical DC- and RF-performance with high accuracy.

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Datasheet Revision History: 17 May 2010

This datasheet replaces the revisions from 02 February 2010 and 30 March 2007. The product itself has not been changed and the device characteristics remain unchanged. Only the product description and information available in the datasheet has been expanded and updated.

Previous Revisions: 02 February 2010 and 30 March 2007				
Page	Subject (changes since last revision)			
1	Higher maximum collector and base currents, higher total power dissipation			
2	Typical values for leakage currents included, maximum leakage currents			
	reduced			
3	Noise description at 100 MHz added			
4	Gain and linearity description at 100 MHz added			
5	Ptot curve adjusted to Ptot and ICmax changes			
5 - 8	Curves for IP3 and noise at 100 MHz added			



Edition 2009-11-16

Published by Infineon Technologies AG 81726 Munich, Germany

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